Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/646,278	SOLOV ET AL.	
Examiner	Art Unit	
Tae H. Yoon	1714	

SEARCHED						
Class	Subclass	Date	Examiner			
526	145	P-J-08	ny			
	317					
	318.41					
AID		1-21-06	n			
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
1					
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	f-f-ot	My.		
Envantor Search	1-21-06	n		